

Notice of References Cited

Application/Control No.

10/767,227

Applicant(s)/Patent Under
Reexamination
WELCH ET AL.

Examiner

HIEU T. HOANG

Art Unit

2452

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,047,322	04-2000	Vaid et al.	709/224
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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